

Search Notes



Application/Control No.

10/687,603

Examiner

Sang Y. Paik

Applicant(s)/Patent under
Reexamination

HAN ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	4143.1 4150.1		
	4152.11		
	4155.12		
	136		
	138		
	139		
	141		
99	318		
	319		
	389		
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	392		
	393		
	422		
	425		
		4/20/06	18
updated		9/27/06	18

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST TEX REPAIRING	4/14/06	18